## DESIGN/PROCESS CHANGE NOTIFICATION -- FINAL

This is to inform you that a design and/or process change will be made to the following product(s). This notification is for your information and concurrence.

If you require data or samples to qualify this change, please contact **Fairchild Semiconductor** within 30 days of receipt of this notification.

Updated process quality documentation, such as FMEAs and Control Plans, are available for viewing upon request.

If you have any questions concerning this change, please contact:

<u>Technical Contact:</u> Name: Kim, Jongphil E-mail: jpkim@fairchildsemi.co.kr Phone:

<u>PCN Originator:</u> Name: Chuah, Keat Yi E-mail: keatyi.chuah@fairchildsemi.com Phone:

Implementation of change: Expected 1st Device Shipment Date: 2011/09/17

Earliest Year/Work Week of Changed Product: 2010/30

Change Type Description: Alternate Fab Location

Description of Change (From): High voltage high speed power switch application NPN transistors fabricated at Fairchild Korea.

Description of Change (To): High voltage high speed power switch application NPN transistors fabricated at an alternative fabrication facility located in China.

Reason for Change : This change is being made to increase production capacity and provide better supply chain flexibility. Other similar Fairchild products have previously been qualified and are being produced in this alternate fabrication facility. Affected products will be fully compliant to all published data sheet specifications and package outline drawings. Quality and reliability will remain at the highest standards already demonstrated with Fairchild's existing products. If you require data or samples to evaluate this change, please contact Fairchild Semiconductor within 30 days of receipt of this notification. This change is planned to take effect in 90 calendar days from the date of this notification. Please work with your local Fairchild sales representative to manage your inventory of unchanged product if your evaluation of this change will require more than 90 calendar days.

Qual/REL Plan Number(s): Q20100398

Qualification :

The qualification results meet all our criteria for qualifying alternate fabrication site and the overall reliability of our products.

## Results/Discussion for Qual Plan Number(s): Q20100398

Test: (Autoclave)	Cond	itions: 100%R	H, 121C	Standa	rd: JESD2	22-A1	02		
Lot		Device		48-HOI	48-HOURS			Failure Code	
Q20100398AAACLV FJPF		FJPF13009	JPF13009		0/77				
Q20100398AAACLV		FJPF13009				0/7	7		
Q20100398ABACLV		FJPF13009		0/77	0/77				
Q20100398ABACLV		FJPF13009				0/7	7		
Q20100398ACACLV		FJPF13009		0/77	0/77				
Q20100398ACACLV		FJPF13009					7		
Test: (High Tempe	rature	Reverse Bias	s)   Condit	tions: 15	0C, 560V	Sta	ndard: JESD2	22-A108	
Lot	Dev	ice	168-H	OURS	500-HOUR	٢S	1000-HOURS	Failure Code	
Q20100398AAHTRB			0/77						
					0/77				
							0/77		
Q20100398ABHTRB					0/77				
							0/77		
Q20100398ACHTRB					0/77				
							0/77		
Test: (High Tempe	rature	Storage Life)	Conditio	ons: 150	C   Stand	ard: 、	JESD22-A103		
Lot	Dev	ice 168-HOU		OURS	500-HOURS		1000-HOURS	Failure Code	
Q20100398AAHTSL		0/77							
					0/77				
							0/77		
Q20100398ABHTSL					0/77				
							0/77		
Q20100398ACHTSL					0/77				
							0/77		
Test: (Temperature	Cycl	e)   Conditions	s: -65C, 1	50C   St	andard: J	ESD2	22-A104		
Lot		Device	vice 200-CY(		CLES 500		-CYCLES	Failure Code	
Q20100398AATMCL1		FJPF13009		0/77					
Q20100398AATMCL1		FJPF13009				0/7	7		
Q20100398ABTMCL1		FJPF13009		0/77					
Q20100398ABTMCL1		FJPF13009				0/7	7		
Q20100398ACTMCL1		FJPF13009		0/77					
Q20100398ACTMCL1		FJPF13009				0/7	7		
Test: (Temperature	Hum	idity Biased T	est)   Cor	nditions:	85%RH, 8	85C,	100V   Standa	ard: JESD22-A10	D1
Lot	Dev	ice	168-H	OURS	500-HOUR	RS	1000-HOURS	Failure Code	
Q20100398AATHBT			0/77						
					0/77				
							0/77		
Q20100398ABTHBT			0/77						
					0/77				
							0/77		
Q20100398ACTHBT					0/77		1		
							0/77		

Product Id Description : High voltage high speed power switch application NPN transistors.

## Affected FSIDs :

405220TH E080	405220TLL SN00120	
49522010_F080	49522010_31000120	FJE3303HTTU
FJE3303H2TU	FJN3303BU	FJN3303FBU
FJN3303FTA	FJN3303TA	FJP5027OTU
FJP5027RTU	FJPF5027OTU	FJPF5027RTU
KSC2333YTU	KSC3569YTU	KSC5338DTU
KSC5338D	KSH47TF	KSH50TF
MJD47TF	MJD50TF	TIP47TU
TIP47	TIP48TU	TIP48
TIP49	TIP50TU	TIP50